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# Test Beam Analysis of the First CMS MB2 Drift Tube Muon Chamber

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## Abstract

In October 2001 the first MB2 DT chamber, produced at Madrid, was tested at the CERN Gamma Irradiation Facility (GIF) using a muon beam. A RPC was attached to the top of the chamber, and operated coupled together for the first time. The performance of the DT chamber was studied for several operating conditions, and for gamma rates similar to the ones expected at LHC. In addition, part of the associated readout electronics was tested using a beam with the same LHC bunch structure. The

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purpose was to validate the present design for the Read Out Board (ROB) and high performance TDC (HPTDC) chips. This note presents our analysis of the data. The results in all cases are considered satisfactory.

# **1** Introduction

The CMS Barrel Muon Detector consists of four layers of stations, known as MB1, MB2, MB3 and MB4. The two inner ones, MB1 and MB2, are equipped with chambers, based on a multilayer configuration of Drift Tubes (DT), each chamber having attached two double-gap RPC (Resistive Plate Chamber) planes, one at the top and another one at the bottom. In the case of the MB3 and MB4 drift tube chambers, only one RPC layer is attached. More information about these chambers, Drift Tubes and RPCs, concerning the detection and trigger aspects, can be found in [1, 2, 3]. Results about the performance of the Drift Tubes obtained with prototypes can also be found in [4] and references therein.

This paper deals no longer with prototypes but with a final chamber, the first one produced, which was tested at the GIF (Gamma Irradiation Facility) for about 2 periods of 7 days in October 2001. The chamber is a MB2 with 3 superlayers ( $2 \phi$  and  $1 \theta$ ) glued together and to a 128 mm thick honeycomb panel. Each superlayer has four layers of drift tubes. The tube cross section is  $42 \times 13 \text{ mm}^2$ , corresponding to the new drift cell design [5]. All wires inside a superlayer are parallel, with those in even layers staggered by one half cell with respect to those in odd layers. In addition, one RPC (RB2) was attached to the top phi superlayer.

The main goal of this test beam was to certify that the performance of a full chamber in an environment with noise conditions similar to the ones expected at LHC, satisfies all the CMS requirements. It was also important to check, and this was the first time it could be done, that the DT and the RPC work properly when coupled together. A final version of one ROB (ReadOut Board), designed at CIEMAT, was connected to 96 channels of the chamber. It was therefore possible to validate also during this test, for the first time, the performance of this important component of the final readout chamber electronics. The second data taking period was particularly relevant for the test of the ROB since the beam had the 25 ns LHC bunch structure. Results of the analysis of the RPC data alone have been presented elsewhere [6].

# 2 Experimental Setup

The MB2 chamber was installed inside the GIF experimental zone, schematically shown in Figure 1. In addition to a set of scintillator counters providing the trigger, three delay chambers were used to track the incident muons. The beam covered a chamber area of about  $10 \times 10 \text{ cm}^2$ ; its angular spread was ~ 2 mrad. Background produced by a  $Cs^{137}$  gamma source, located 4 meters upstream of the chamber, could be switched on and off, and its flux regulated by a system of lead filters. Out of the 17 available attenuation factors 4 were used: 5, 10, 50 and 100, the smallest one providing a background a factor 2 larger than the maximum one to be expected during LHC operation in any of the DT chambers in CMS.

In addition to different background fluxes, data were taken with different conditions of voltage settings, discriminator thresholds, and the RPC HV switched on and off. We used special runs to measure noise (beam off), and



Figure 1: Schematic representation of the GIF test setup at the CERN West area.

test pulse runs for calibration purposes. Most of the time the chamber was placed perpendicular to the beam, with superlayer  $\phi_1$  in front, followed by the honeycomb panel, superlayer  $\theta$ , and superlayer  $\phi_2$ . No special support allowing translations and rotations was available, but the chamber was moved twice in order to have three different regions being hit by the incident muons. In total ~ 200 runs, each one having typically 100,000 events, were taken.

During the first test beam period, P2B, the muon beam was non structured with an intensity of about 1200 triggers/s. Spill duration was 5.1 seconds and the repetition period was 16.8 seconds. During the second period, P2C, the beam had a 25 ns structure and the trigger rate was 5000 triggers/s.

Multi-hit CAEN TDCs were used for the readout of the discriminated signals coming from the chamber front end electronics. Hits were recorded in a window 4  $\mu$ s wide started by the trigger signal. One TDC count corresponded to 25/32 ns ~ 0.78 ns. Most of the results reported in this paper (Sections 3, 4, 5, 6, and 7) were obtained from the analysis of the data taken with these commercial TDCs. But, in addition, one ROB equipped with 4 high performance TDC (HPTDC) chips was also connected part of the time to 96 chamber channels as previously mentioned. A test jig was developed to implement ROB control and data acquisition. The ROB was connected through a set of purpose dedicated boards and a VME interface to a PC for HPTDC programming and monitoring. Control of the readout system, data decodification and spill management was done by software. More details about the ROB and results concerning its performance will be presented in Section 8.

## **3** Pulser runs

At the debugging stage, and previously to every physics run, pulser runs were recorded. Test pulses were produced by a pulse generator, split into two similar input pulses by a splitter box, and injected at the electronics front-end. One of the inputs fed wires in layers #1 and #3, and the other layers #2 and #4. The splitter box can introduce a relative delay between the two output pulses, useful for trigger electronics test purposes.

Pulser runs were first used to check the integrity of the whole readout chain. Figure 2(left) shows the cell occupancy in a pulser run with  $10^4$  events. The vertical lines limit the cabled detector regions. One can observe typical DAQ inefficiencies of the order of 1%, reaching ~ 8% in the worst case. Most important is that inefficiencies appear always in blocks of 32 contiguous channels corresponding to the granularity of a TDC buffer. In the cases where one or several channels in the block are noisy, the noise hits can overflow the buffer, and the test pulse hits are lost before actual readout. At a practical level, this inefficiency just meant that in order to avoid distortions of the data, one had to make sure that all the channels illuminated by the beam in every superlayer fit together in one of the blocks.

Relative  $T_0$ s were calculated from the leading edge arrival time of the measured pulse. Figure 2(right) shows the output time distribution for a typical channel in pulser Run 621. The test pulse time resolution is in the range 0.4 – 0.6 TDC counts, with all the entries in essentially two TDC bins. Figure 3(left) shows the average output time as a function of the channel number in pulser Run 621. These numbers were used in the offline analysis for relative  $T_0$  subtraction.

We also investigated the dependence of the output time on the discriminator threshold value. Figure 3(right) shows the time shifts as a function of the threshold for all pulser runs. The shifts are defined with respect to the 10 mV threshold average time value. The dependence is approximately linear. From a linear fit, a slope of  $0.078 \pm 0.001$  ns/mV is observed.

# 4 Physics runs

The chamber nominal conditions in physics runs were  $V_{wire} = 3.6$  kV,  $V_{strip} = 1.8$  kV,  $V_{cath} = -1.2$  kV, and a discriminator threshold of 15 mV. The typical beam spread covered 4 drift cells in the  $\phi$  superlayers (6 cells in the  $\theta$  superlayer), corresponding to a total of 16 (24) TDC channels. The proportion of noise hits, dominated by beam-induced backgrounds, was smaller than  $10^{-3}$ . In this section, we discuss in detail the calibration and analysis procedures. For illustration purposes we use Run 624.

## 4.1 Calibration and alignment

Hit data must first be corrected for relative and global  $T_0$ . The relative  $T_0$  subtraction method has been described in the previous section. Global  $T_0$ s were equalized looking at the leading edge of the signal time-box using the derivative method. Figure 4 shows a typical time-box distribution at nominal chamber conditions. Six global  $T_0$ 



Figure 2: (Left) Cell occupancy in a pulser run with  $10^4$  events. The vertical lines limit the cabled regions. Inefficiencies in blocks of 32 channels are observed. (Right) Output time distribution for a typical channel in pulser Run 621.



Figure 3: (Left) The average output time as a function of the channel number in pulser Run 621. The vertical lines limit the cabled regions. These numbers are used for relative  $T_0$  subtraction. (Right) Time shifts as a function of the threshold level for pulser runs. The shifts are defined with respect to the 10 mV threshold average time value. From a linear fit, a slope of  $0.078 \pm 0.001$  ns/mV is observed.

adjustments were calculated, one for the odd (even) layers in each one of the three superlayers. As the input test pulses are different, one has to allow for a possible time shift. In fact, a shift larger than 1 ns was observed for the  $\theta$  superlayer.

Figure 5(left) shows the derivative of the time-box distribution. Figure 5(right) shows the derivative in the leading edge region, where a Gaussian fit has been performed. A sigma of  $2.68 \pm 0.05$  ns is observed. Gaussian widths were in the range 2.4 - 2.7 ns for the  $\phi$  superlayers (2.9 - 3.0 ns for the  $\theta$  superlayer). The  $T_0$  is defined as the Gaussian mean value minus 5 ns. This corresponds to two average sigmas in the negative side of the Gaussian. We preferred to use an average sigma instead of every individual sigma to be less sensitive to the statistical fluctuations of each fit.

Hits in every superlayer were fitted to a straight segment by minimizing the  $\chi^2$ . All possible fits with at least three hits were studied. No  $\chi^2$  cut was attempted at this stage in order to avoid any bias on data selection. To maximize the hit finding efficiency a fit with 4 hits was always preferred to a fit with three hits. For the same number of hits, the fit with the best  $\chi^2$  was chosen. In the following analysis only the best fit in every superlayer was considered. In the majority of the cases the presence of several fits was the result of the coincidence of several beam muons traversing the chamber (see subsection 6.2). Figure 6(left) shows the  $\chi^2$  distribution for segments with 4 hits in superlayer  $\phi_1$ . Units are mm<sup>2</sup><sup>1</sup>.

Drift velocities were estimated using the meantime method. The meantime  $(MT_j)$  is defined as

$$MTj = \frac{1}{2} \cdot \left[ T(j) + T(j+2) + 2 T(j+1) \right]$$

where T(j), T(j + 1), and T(j + 2) are the drift times measured in three successive layers (j, j + 1, and j + 2), and layer (j + 1) is staggered by half a cell with respect to the other two. The central layer in MT1 (MT2) is #2 (resp., #3).

The histogram in Figure 6(right) shows the meantime (MT1) distribution for 4-hit segments in superlayer  $\phi_1$ . The meantime distribution peaks at the maximal drift time. The tail on the left of the distributions is produced when one or more hits in the fit were produced by delta-rays. Considering only 4-hit segments with  $\chi^2 < 0.3 \text{ mm}^2$  eliminates the tail, without disturbing its Gaussian core (points in Figure 6(right)).

Figure 7 shows the four meantime distributions, after relative and global  $T_0$  adjustment, for 4-hit segments in superlayer  $\phi_1$  with  $\chi^2 < 0.3$  mm<sup>2</sup>. L(eft) and R(ight) denote the segment relative position with respect to the wire in layer #1.

The meantime distributions in Figure 7 were fitted to a Gaussian shape. Taking into account the maximal drift time and the cell maximal drift distance (21 mm) the drift velocity is measured. In Figure 7, the mean values of the left and the right Gaussian fits are shifted in opposite directions due to wire position misalignment ( $\pm 0.2$  ns for MT1,  $\pm 1.0$  ns for MT2). In contrast, the average of the two mean values is insensitive to any misalignment. This can be tested by comparing the average of MT1s to the average of MT2s: for instance in Figure 7 they agree at the 0.1 ns level. The maximal drift time was thus estimated using the average of the four Gaussian mean values.

The meantime fit mean values and corresponding drift velocities for the three superlayers in Run 624 are summarized in Table 1.

The statistical error in the drift velocity is very small. Systematic errors were estimated by moving around the global  $T_0$  by 1 ns. It is important to note that the drift velocity values depend on the adopted  $T_0$  determination. Without an external position reference all the fits satisfying the relation

$$2 \Delta T_0 v_d - T_{max} \Delta v_d = 0$$

are equivalently good (neglecting quadratic corrections). This formula means that a change in the drift velocity

<sup>&</sup>lt;sup>1)</sup> The standard  $\chi^2$  is defined as the sum of the squared residuals divided by the resolution squared, therefore it is a dimensionless quantity. In this note we call  $\chi^2$  only to the numerator (therefore with dimensions of length squared). The reason to do this is that the denominator, the resolution squared, is a result of the analysis itself and it is not known a priori. On the other hand, in this analysis the resolution is assumed to be the same for all events. Therefore the denominator is just a constant, and, since the  $\chi^2$  is only used for minimization and cutting purposes, it is equivalent to use the standard  $\chi^2$  or a quantity proportional to it. An alternative definition (numerically equivalent) is that our  $\chi^2$  is defined for a pseudo-resolution of 1 mm.



Figure 4: Typical drift time-box distribution after relative  $T_0$  correction. This distribution is used for global  $T_0$  determination.



Figure 5: (Left) Derivative of the drift time distribution (arbitrary units). (Right) Detail of the derivative distribution in the leading edge region. The parameters of a Gaussian fit are given. A sigma of  $2.68 \pm 0.05$  ns is observed.



Figure 6: (Left) The  $\chi^2$  distribution for 4-hit segments in superlayer  $\phi_1$  (Run 624). Units are mm<sup>2</sup>. The parameters of an exponential fit to the region  $\chi^2 < 0.2 \text{ mm}^2$  are given. (Right) Meantime (MT1) distribution for 4-hit segments in superlayer  $\phi_1$  (Run 624). The histogram is for all segments, the points for the subset satisfying  $\chi^2 < 0.3 \text{ mm}^2$ .

can be perfectly absorbed by a  $T_0$  redefinition, without paying a price in the  $\chi^2$ . From the formula, the systematic error on the drift velocity is 0.3  $\mu$ m/ns.

Once the drift velocities are measured, and since the precision to determine the drift velocity given a  $T_0$ , is better than the precision from the  $T_0$  itself, one can choose instead to fix the drift velocities to a given value inside the systematic window [7]. It is expected that the calibration procedure will be better defined, and the measurement of all other relevant quantities much less sensitive to the statistical fluctuations in the  $T_0$  determination. This is particularly important since the main results in this note stem from the comparison of the parameters measured in several runs taken under different conditions.

Consequently, the drift velocities were fixed at 55  $\mu$ m/ns and the segments re-fitted. Comparing to the drift velocity values above, all the  $T_0$ s had to be adjusted by a fraction of one resolution sigma.<sup>2)</sup>

After  $T_0$  and drift velocity determination, one can use the residual distributions to align the position of the wires. Figure 8 shows the residual distributions for 4-hit segments in superlayer  $\phi_1$ . The mean values obtained after fitting a Gaussian shape are then used to calculate the actual wire position displacements.

Missing an external reference the four residuals are not independent, because two degrees of freedom have been absorbed by the fit parameters. These two degrees of freedom correspond physically to an overall translation and rotation offset of the chamber with respect to the beam. Since we are interested only in the relative alignment, one of the displacements can be defined as zero (say the one of layer #1). But to fix the problem one needs another hypothesis. For the case of one superlayer ( $\theta$ ) we adopted the minimal misalignment hypothesis corresponding to the minimal sum of the misalignments squared. In the case of two parallel superlayers one degree of freedom can be fixed imposing that the average slopes in both superlayers coincide. But beyond this, one has to impose again a combined minimal misalignment condition. We note that before imposing a common average slope, the values in the  $\phi_1$  and  $\phi_2$  superlayers differ by 4.0 mrad. This number represents well the size of the expected systematic slope shifts before fine wire alignment at CMS. We will see later that this size is comparable to the intrinsic single superlayer angular resolution, and much larger than the double superlayer combined angular resolution. We finally mention that in the case of two  $\phi$  superlayers, all wire displacements are fixed if the shift between the two superlayers (nominally 42 mm) is known. This is another good reason to find out how to measure this important parameter independently.

The residual fit mean values, and corresponding wire position shifts in Run 624 are summarized for the three

<sup>&</sup>lt;sup>2)</sup> This value of the drift velocity is apparently in disagreement with the one obtained in a previous test beam with the Q4 prototype [8], which was closer to 57  $\mu$ m/ns. The reason is that in [8] a wrong conversion factor was applied to get the time in ns from the TDC used in that occasion. When doing this properly, both values are in perfect agreement.



Figure 7: Meantime distributions, after relative and global  $T_0$  adjustment, for 4-hit segments with  $\chi^2 < 0.3 \text{ mm}^2$  in superlayer  $\phi_1$  (Run 624). The central layer in MT1 (MT2) is #2 (resp., #3). L and R denote the segment relative position with respect to the wire in layer #1. The parameters of the corresponding Gaussian fits are given.

	SL $\theta$	SL $\phi_1$	$\operatorname{SL}\phi_2$
MTL1 (±0.02)	377.8	381.5	380.3
MTR1	383.2	381.0	381.0
MTL2	378.2	380.4	379.2
MTR2	382.5	382.3	381.8
Average MT	380.4	381.3	380.6
$\Delta$ MT1	$\pm 2.7$	$\pm 0.2$	$\pm 0.4$
$\Delta$ MT2	$\pm 2.1$	$\pm 1.0$	$\pm 1.3$
Drift velocity $(\pm 0.3)$	55.21	55.07	55.18

Table 1: Summary of the meantime Gaussian mean values (ns), after  $T_0$  adjustment, and corresponding drift velocities ( $\mu$ m/ns) for the three superlayers in Run 624.



Figure 8: Residual distributions, after  $T_0$  and drift velocity calibration, for 4-hit  $\phi_1$ -segments with  $\chi^2 < 0.3 \text{ mm}^2$  (Run 624). The parameters of the corresponding Gaussian fits are given. All offsets are within  $\pm 50 \mu \text{m}$ .

	SL $\theta$	SL $\phi_1$	SL $\phi_2$
Residual layer #1 ( $\pm 0.3$ )	-39.3	25.8	15.4
Residual layer #2	85.8	-17.9	1.2
Residual layer #3	-54.5	-39.0	-47.6
Residual layer #4	8.4	33.0	32.0
$\Delta x_2$	108.3	-18.0	-22.2
$\Delta x_3$	-48.3	-16.2	-80.1
$\Delta x_4$	-3.9	85.2	-7.6

Table 2: Summary of the residual Gaussian mean values ( $\mu$ m), after  $T_0$  and drift velocity calibration, and corresponding wire misalignments ( $\mu$ m) for the three superlayers in Run 624. The average beam slopes in superlayers  $\phi_1$  and  $\phi_2$  have been constrained to be equal.

	SL $\theta$	$\operatorname{SL}\phi_1$	$\operatorname{SL}\phi_2$
MTL1	$186.8\pm0.4$	$178.3\pm0.4$	$181.5\pm0.4$
MTR1	$177.5\pm0.4$	$184.1\pm0.4$	$186.4\pm0.4$
MTL2	$186.5\pm0.4$	$185.0\pm0.4$	$185.0\pm0.4$
MTR2	$183.6\pm0.4$	$185.0\pm0.4$	$181.9\pm0.4$
Residual layer #1	$186.7\pm0.4$	$178.4\pm0.4$	$175.8\pm0.4$
Residual layer #2	$188.8\pm0.5$	$180.1\pm0.5$	$183.9\pm0.5$
Residual layer #3	$190.4\pm0.5$	$184.4\pm0.5$	$178.3\pm0.5$
Residual layer #4	$188.2\pm0.4$	$179.3\pm0.4$	$177.8\pm0.4$
Efficiency	$99.92 \pm 0.01$	$99.97 \pm 0.01$	$99.97 \pm 0.01$

Table 3: Summary of hit position resolution estimators ( $\mu$ m) and cell efficiencies (%), after  $T_0$ , drift velocity, and wire position adjustments, for the three superlayers in Run 624.

superlayers in Table 2.

Since the wire position shifts are just of geometrical nature, a cross-check of the calibration and alignment procedure is provided by the stability of the values. Figure 9 shows the wire alignment parameters calculated for several different runs (parameterized using the corresponding wire voltage value), at two positions in the chamber. The same values, within a few microns, are consistently found.

#### 4.2 Stand-alone parameter determination

After calibration and alignment, we are ready to measure the most important chamber performance parameters: linearity, resolutions, and efficiencies.

A good final check of the calibration and alignment procedure is that the  $\chi^2$  distribution of the fitted segments should look like a  $\chi^2$  distribution. Particularly interesting is the one corresponding to 4-hit segments shown in Figure 6(left), that should be an exponential for the events where the 4 hits are good (Gaussian statistics). Deviations from the exponential shape are interpreted as fits where (at least) one of the hits was originated by a delta-ray. We performed an exponential fit of the data points in Figure 6(left) with  $\chi^2 < 0.2 \text{ mm}^2$ . The parameters of the fit are given in the Figure. From the slope a hit position resolution of  $179.0 \pm 0.4 \mu \text{m}$  is deduced, implying that the cut  $\chi^2 < 0.3 \text{ mm}^2$  is at the 3-sigma level. Comparing the integral of the exponential curve to the measured number of events, the power of this cut to discriminate 4-good-hit segments from delta-ray contaminated ones can be quantified. More than 90% of the 4-good-hit segments satisfy the cut, yet the delta-ray contamination is kept at a few percent level.

Considering the 4-hit events with  $\chi^2 < 0.3 \text{ mm}^2$ , Figure 10 shows again the four calibrated meantime distributions in superlayer  $\phi_1$ . One can see that the shifts L-R are now  $\pm 0.1 \text{ ns} (\pm 0.2 \text{ ns})$  for MT1 (resp., MT2). Both averaged mean values virtually coincide and correspond to the fix drift velocity of 55  $\mu$ m/ns. The four Gaussian sigmas are proportional to the hit position resolution. The values for the three superlayers are summarized in Table 3.

Similarly, Figure 11 shows again the residual distributions in superlayer  $\phi_1$ . The Gaussian offsets are now within  $\pm 10 \ \mu$ m. Again, the four Gaussian sigmas are proportional to the hit position resolution. The values for the three superlayers appear also in Table 3. Agreement among all the different resolution estimators is satisfactory.

Once the basic hit position resolution is known, all other relevant resolutions can be derived, and compared to their experimental values. For instance, Figure 12(left) shows the distribution of the residual mismatch between positions at superlayers  $\phi_1$  and  $\phi_2$ , using the slope of a combined fit to the hits in both superlayers. Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$  in both superlayers. A resolution of  $15.3 \pm 0.4 \mu \text{m}$  is obtained. For a hit position resolution of  $180 \mu \text{m}$ , the expected extrapolation resolution is  $15.5 \mu \text{m}$ .

The single hit detection efficiency is calculated from the ratio of the number of 3-hit segments to the number of 4-hit segments. No  $\chi^2$  cut is implemented here, as the delta-ray hits also are considered to add to the hit efficiency. There are two main reasons that make a cell inefficient. The first one is geometrical, when the muon traversed the I-beam walls separating a drift cell from the next. The second is the genuine detection inefficiency when the muon traversed the detection region.

For perpendicularly incident muons, the cell wall effect ideally means that two hits are lost and no fit is found.



Figure 9: Wire alignment stability for several runs (parameterized using the corresponding wire voltage value), at two different positions in the chamber (squares and dots).



Figure 10: Meantime distributions, after  $T_0$ , drift velocity, and wire position adjustments, for 4-hit segments with  $\chi^2 < 0.3 \text{ mm}^2$  in superlayer  $\phi_1$  (Run 624). The central layer in MT1 (MT2) is #2 (resp., #3). L and R denote the segment relative position with respect to the wire in layer #1. The parameters of the corresponding Gaussian fits are given.



Figure 11: Residual distributions, after  $T_0$ , drift velocity, and wire position adjustments, for 4-hit  $\phi_1$ -segments with  $\chi^2 < 0.3 \text{ mm}^2$  (Run 624). The parameters of the corresponding Gaussian fits are given. All offsets are now within  $\pm 10 \mu \text{m}$ .



Figure 12: (Left) Distribution of the the residual mismatch between positions at superlayers  $\phi_1$  and  $\phi_2$ , using the slope of a combined fit to the hits in both superlayers (Run 624). Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$  in both superlayers. A resolution of  $15.3 \pm 0.4 \mu \text{m}$  is obtained. (Right)  $\chi^2$  versus internal cell position for 3-hit segments in superlayer  $\phi_1$  (Run 624). In the case of the accumulation of events with internal positions close to 0 and 21 mm, the inefficiency is attributed to the cell wall effect. For the central events the inefficiency is genuine. The lines, used later in this analysis, separate both regions.

However sometimes a fit is found after all, contaminating the genuine efficiency calculation. This typically happens when a third hit, originated from a delta-ray, is incorporated into the fit. The effect of this third hit is to pull the fit position away from the wall, simultaneously deteriorating the  $\chi^2$  value. The two samples can therefore be separated attending to the  $\chi^2$  correlation for 3-hit events versus the internal cell position, as illustrated in Figure 12(right) where the previous pattern is obvious. For the accumulation of events with internal positions close to 0 and 21 mm, the inefficiency is attributed to the cell wall effect. For the central events the inefficiency is genuine. The two lines in Figure 12(right) are used to separate both regions. The genuine cell efficiency values obtained in Run 624 for the three superlayers are shown in Table 3.

#### **4.3** Parameter determination using an external reference

In order to provide an external reference for the beam, three delay chambers were used. Chambers #1 and #2 were 6700 mm and 4700 mm upstream respectively. Chamber #3 was 2300 mm downstream, and behind an iron block  $\sim 1$  m thick. The separation between chambers #1 and #2 was measured to be 2000 mm at GIF.

No calibration run of the chambers at GIF was attempted. We use the data instead. In case of several hits, correlation of the various hits showed that the first one in time has to be used. Delay chamber  $T_0$ s are relatively less important as they only shift the average beam position and angle. The slope (assumed to be the same for the three chambers), relative positions, and resolutions were estimated using the separation between chambers #1 and #2 to set the scale in the axial direction, and the DT cell size to set the scale in the transverse direction. Fitting events with one good hit in every chamber to a straight line, the minimum  $\chi^2$  corresponded to a slope of 0.146 mm/ns and a hit position resolution of 930  $\mu$ m for Chambers #1 and #2. For Chamber #3 after adding the effect of multiple scattering, the resolution deteriorates to ~ 1.3 mm. Combining the information of the three delay chambers, the expected extrapolated position resolution). In contrast, the expected angular resolution is ~ 0.2 mrad, much better even than the combined  $\phi_1$ - $\phi_2$  angular resolution.

In this section we select muons measured with both the DT chamber, and with the delay chambers in Run 624. Segments in the DT chamber are required to be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$  in every relevant superlayer. For the delay chambers we require that the interpolation of Chambers #1 and #3 at the position of Chamber #2 agrees with the actual measurement at Chamber #2 within 3.6 mm (3 sigmas).

We first investigate the linearity of the relation distance from the wire versus drift time. Figure 13(left) shows the average measured drift distance in superlayer  $\phi_1$ , as a function of the internal cell position obtained with the delay chambers. The drift distance is the product of the measured drift time times the drift velocity (fixed during calibration at 55  $\mu$ m/ns). The straight lines have slopes ±1. The agreement is good in the region 2.5 mm < |x| < 18.5 mm. Distortions around x = 0 and  $x = \pm 21$  mm are expected due to the vicinity of the wire or I-beam walls, together with the poor delay chamber extrapolation resolution. In Figure 13(right) the deviations from linearity in the previous plot as a function of the cell internal position are observed in detail. All deviations are well within ±100  $\mu$ m.

We now turn to the measurement of the muon position and angle resolutions. Figures 14 compare the measured horizontal angular (left) and position (right) beam profiles. The histograms were obtained using a combined fit to the hits in superlayers  $\phi_1$  and  $\phi_2$ . The dots were obtained using the delay chambers for the same events.

Figure 15 shows the distribution of the difference in angle obtained with superlayer  $\phi_1$ , with respect to the value measured using the delay chambers. A single superlayer angular resolution of  $6.57 \pm 0.02$  mrad is obtained. For a hit position resolution of  $180 \ \mu$ m, a resolution of  $6.20 \ m$ rad is expected.

Figure 16 shows the distribution of the difference in angle (left) and position (right) measured using a combined fit to the hits in superlayers  $\phi_1$  and  $\phi_2$ , with respect to the values measured using the delay chambers. A position resolution of  $0.976 \pm 0.007$  mm (dominated by the error on the delay chamber extrapolation, as explained above), and a combined angular resolution of  $0.574 \pm 0.008$  mrad are obtained. For a hit position resolution of  $180 \ \mu$ m, a position resolution of  $6.53 \ \mu$ m and an angular resolution of  $0.53 \ \mu$ m are expected.

# 5 Test beam results

In this section we investigate the evolution of the chamber performance parameters, when the operating conditions are changed.

## 5.1 High voltage scan

We studied the dependence of the drift velocity, resolution, and efficiency as a function of the wire and cathode voltages. In the first case, for constant  $V_{strip} = 1800$  V and  $V_{cath} = -1200$  V, the wire voltage was changed in the range 3400 - 3625 V at two different chamber positions.

The gas gain depends essentially on the amplification voltage, defined as the difference between the wire and strip voltages. For constant  $V_{strip}$ , a change in  $V_{wire}$  in the previous range corresponds to a change in the amplification voltage in the 1600 - 1825 V range. The procedure described above was used to calibrate the runs with different values of  $V_{wire}$ . As explained in Section 4.1, once the  $T_0$  is defined for each run from the derivative of the time box distribution (Gaussian mean value minus 5 ns), the drift velocity can be estimated from the meantime distributions. Figure 17(left) shows the values obtained for the drift velocities as a function of  $V_{wire}$ . Within errors the drift velocity is constant and close to the 55  $\mu$ m/ns value that we use later as a fixed value to recalculate the  $T_0$ s and to measure the rest of the chamber parameters.

Previous analyses [1, 4] reported observations of a drift velocity dependence at a few percent level with the amplification voltage. This discrepancy can be understood by considering the correlation between  $T_0$  and drift velocity, and the variation with the amplification voltage of the time resolution which affects significantly the  $T_0$  definition when using alternative approaches (for instance through the changing width of the time derivative distribution: the sigma of this distribution turns out to vary from 5.3 ns at  $V_{wire} = 3500$  V to 2.7 ns at  $V_{wire} = 3625$  V).

Figure 17(right) shows the hit position resolution as a function of  $V_{wire}$ , for segments with 4 hits and  $\chi^2 < 0.3$  mm<sup>2</sup>, and both using the MT and Residual computation methods. Figures 18 show the measured efficiencies as a function of  $V_{wire}$ . A summary of all measurements can be found in Table 4. For a wire voltage value of 3550 V the resolution is still better than 220  $\mu$ m and the efficiency 99.85%.

The cathode voltage was changed in order to test the parameter dependence on the drift voltage, defined as the difference between the strip and cathode voltages. The drift voltage value is responsible for the electric field values along the cell. In this test, cathode voltages in the range 1200 - 1400 V were studied, corresponding to drift voltage values between 3000 - 3200 V. For electric fields in this region, the drift velocity is expected to be saturated. No significant dependence of any chamber performance parameter on  $V_{cath}$  has been observed in this analysis.



Figure 13: (Left) The average measured drift distance in superlayer  $\phi_1$ , as a function of the internal cell position obtained with the delay chambers (Run 624). Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$ . The straight lines have slopes ±1. (Right) Deviations from linearity in the previous plot, as a function of the cell internal position obtained with the delay chambers. All values are well within ±100  $\mu$ m.



Figure 14: The measured horizontal angular (left) and position (right) beam profiles. The histograms were obtained using a combined fit to the hits in superlayers  $\phi_1$  and  $\phi_2$ . Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$  in both superlayers. The dots were obtained using the delay chambers for the same events.



Figure 15: Distribution of the difference in angle obtained with superlayer  $\phi_1$ , with respect to the value measured using the delay chambers (Run 624). Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$ . A single superlayer angular resolution of  $6.57 \pm 0.02$  mrad is obtained.



Figure 16: Distribution of the difference in angle (left) and position (right) measured using a combined fit to the hits in superlayers  $\phi_1$  and  $\phi_2$ , with respect to the values measured using the delay chambers (Run 624). Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$  in both superlayers. A combined angular resolution of  $0.574 \pm 0.008$  mrad, and a position resolution of  $0.976 \pm 0.007$  mm (dominated by the error on the delay chamber extrapolation, see text) are obtained.



Figure 17: (Left) The measured drift velocity dependence on the wire voltage. Error bars are dominated by the systematics related to a change of  $\pm 1$  ns in the  $T_0$  subtraction. (Right) Hit position resolutions (averaged over the three superlayers and over two positions in the chamber) as a function of the wire voltage. The resolutions have been obtained using both the Meantime and Residual computation methods. Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$ .



Figure 18: (Left) Hit efficiency dependence on the wire voltage. (Right) Detail of the efficiencies for  $V_{wire} \ge 3500$  V.

Wire Voltage (V)	3400.	3500.	3550.	3575.	3600.	3625.
Drift Velocity	$54.9\pm0.7$	$55.1 \pm 0.3$				
Resolution (MT)	$276 \pm 2$	$237 \pm 1$	$211 \pm 1$	$200 \pm 1$	$191 \pm 1$	$184 \pm 1$
Resolution (Residuals)	$286 \pm 1$	$241 \pm 1$	$210 \pm 1$	$198 \pm 1$	$186 \pm 1$	$180 \pm 1$
Efficiency	$89.77\pm0.14$	$99.13 \pm 0.01$	$99.85 \pm 0.01$	$99.94 \pm 0.01$	$99.97 \pm 0.01$	$99.97 \pm 0.01$

Table 4: Summary of the measured drift velocities ( $\mu$ m/ns), hit position resolutions ( $\mu$ m) and cell efficiencies (%), as a function of the wire voltage.

## 5.2 Signal propagation velocity along the wire

Data were taken at three different positions along the wire for the same cells of  $\theta$  superlayer. Comparing the global  $T_0$  shifts against the corresponding beam average positions, measured with the  $\phi$  superlayers, a signal propagation velocity of  $207 \pm 21$  mm/ns was obtained (Figure 19).

## 5.3 Threshold level scan

Analogously to subsection 5.1, the dependence of the chamber performance parameters on the discriminator threshold level was investigated. The threshold levels were changed in the range 10 - 30 mV, equivalent to 3 fC - 9 fC of integrated charge.

Figures 20 show the global  $T_0$  shifts (left), and corresponding drift velocity (right) dependence on the threshold level. The shifts are defined with respect to the 10 mV threshold  $T_0$  value. From a linear fit, a slope of  $0.146\pm0.001$  ns/mV is observed. Note that the slope for pulser runs is significantly smaller (Fig. 3(right)), evidencing the different pulse shapes (faster rise time in the test pulse case, as expected). Correspondingly, the apparent drift velocity decreases with the threshold. Error bars on the drift velocities are dominated by the systematics related to a change of  $\pm 1$  ns in the  $T_0$  subtraction.

Figure 21(left) shows the hit position resolution dependence on the threshold value, measured with 4-hit segments having  $\chi^2 < 0.3 \text{ mm}^2$ . Also, in Figure 21(right) and in Table 5, the cell efficiency dependence on the threshold



Figure 19: Global  $T_0$  shifts for three positions along the wire in the  $\theta$  superlayer. From the slope of the linear fit, a signal propagation velocity of  $207 \pm 21$  mm/ns is obtained.

Threshold (mV)	10	15	20	30
Source off	99.99	99.97	99.95	99.87
Filter 100	99.99	99.97	99.95	99.83
Filter 50	99.98	99.97	99.94	99.80
Filter 10	99.97	99.96	99.93	99.82

Table 5: Summary of the cell efficiencies (%) measured as a function of the threshold level and for several conditions of gamma irradiation. All efficiencies have a statistical error of  $\pm 0.01\%$ .

	SL $\theta$	SL $\phi_1$	SL $\phi_2$
$R_0$ (Hz)	$42\pm3$	$37\pm2$	$42\pm2$
$R_1 ~({\rm Hz/cm^2})$	$99\pm13$	$145\pm13$	$69\pm5$
k	$0.89\pm0.04$	$0.89\pm0.03$	$0.86\pm0.02$
$\mathcal{F}$	$7.7\pm0.7$	$7.8\pm0.4$	$7.3\pm0.4$

Table 6: Parameters of the fit to the noise occupancy as a function of the source filter value, for the three superlayers. The meaning of the parameters is explained in the text.

level (squares) is summarized. Both the hit resolution and the cell efficiency deteriorate as the threshold grows, as expected. Even for a threshold value of 30 mV (9 fC) the resolution is below 220  $\mu$ m and the efficiency larger than 99.85%.

# 6 Noise effects

In this section we investigate the behavior of the chamber performance parameters in the presence of several levels of noise, corresponding to different filters of the gamma source. The noise signals are produced by photon conversion at the chamber walls, and further ionization of the cell gas by the  $e^+ - e^-$  tracks.

## 6.1 Noise occupancy levels

We first compute the noise occupancy normalization, measured in noise runs. Events in noise runs are selected with random triggers in anti-coincidence with the "SPILL ON" signal. Figures 22 show the noise occupancies as a function of the cell number for the three superlayers. The left plot was obtained with the gamma source off. The right plot is for gamma irradiation corresponding to a filter of 10. Figure 23(left) shows the noise cell occupancy, averaged over all the cells in a given superlayer, for the three superlayers, as a function of the source filter value (F). The measured points are expected to be given by the formula

$$R(F) = R_1 \exp(-k \log(F)) + R_0$$
(1)

where  $R_0$  represents the intrinsic noise rate. The parameter k (if different from 1) translates from the nominal filter value to the actual one. Defining  $\mathcal{F} = 10^k$ , this number gives the actual reduction filter when a nominal filter of 10 has been applied. The parameter  $R_1$  represents the noise level without filter (F = 1). The fits are superimposed in Figure 23(left), the parameters given in Table 6.

The parameters  $R_0$  and k (thus  $\mathcal{F}$ ) appear to be superlayer-independent as expected. Calculating the corresponding averages over the three superlayers gives:

$$R_0 = 40 \pm 1 \text{ Hz}, \ k = 0.88 \pm 0.02, \ \mathcal{F} = 7.5 \pm 0.3$$

Note that the results on chamber performance discussed in the previous sections were obtained in the presence of a noise level given by  $R_0$ . The hit background level, in the cells hit by the beam, is of order  $10^{-4}$ , and therefore negligible. Indeed this noise was hidden below other small beam-related backgrounds in normal physics runs.

The values of the  $R_1$  noise as a function of the superlayer change as expected, given their position and relative shadowing, in the face of the gamma source. The noise levels during LHC operation (originated on neutron



Figure 20: Global  $T_0$  shifts (left), and corresponding drift velocity (right) dependence on the threshold level. The shifts are defined with respect to the 10 mV threshold  $T_0$  value. From a linear fit, a slope of  $0.146 \pm 0.001$  ns/mV is observed. Error bars on the drift velocities are dominated by the systematic related to a change of  $\pm 1$  ns in the  $T_0$  subtraction.



Figure 21: (Left) Hit position resolution dependence on the threshold value. Segments must be 4-hit and have  $\chi^2 < 0.3 \text{ mm}^2$ . (Right) Cell efficiency dependence on the threshold level, for two conditions of gamma irradiation: source off (squares) and filter 10 (circles).

capture) correspond to nominal filters in the approximate range F = 20 - 300 (10 - 125) in superlayer  $\phi_1$  (resp., in superlayer  $\phi_2$ ). For the smallest absorption filter value studied here (F = 5), the noise level is 3.5 (1.7) times larger than the maximum one expected at LHC in any barrel muon chamber.

Figure 23(right) shows the dependence of the noise level on the discriminator threshold, for a source filter of 10. The dependence is rather mild, as the noise hits are originated by charged track ionization. Even with a threshold of 30 mV, the noise rate is only reduced to ~ 90%. On the other hand, the  $e^+ - e^-$  pair is quickly absorbed, and noise hits in different layers are expected to be rather uncorrelated. The noise is not assumed to generate by itself fake muons. To quantify this, we fitted segments in a pure noise run (Run 650, filter 10). In 70,000 events only one segment resembling a muon was found.

#### 6.2 Chamber performance in the presence of noise

In this subsection the influence of noise at the muon level is measured. In particular two topics should be clarified. First, how the noise disturbs the identity and relative frequency of the fit segments. Second, how much the chamber performance parameters change in the presence of noise.

In order to do this, we started by modifying the fit algorithm. In the previous sections, a fit algorithm designed to maximize the efficiency in the absence of noise has been used. This fit algorithm was adequate in the idealized conditions of a test beam environment. However, in the presence of noise, pure hit efficiency is not always desired, as it might mean the inclusion of noise hits, and degradation of the fit segments.

The fit algorithm required in this section is more like the one that will used at LHC, where often one will prefer a good fit with 3 hits from a bad 4-hit fit. We implement this condition by considering hits in the time window  $0 < T_{hit} < 400$  ns, and requiring (conservatively)  $\chi^2 < 1$  mm<sup>2</sup>.

If the  $\chi^2$  of a 4-hit segment is larger than 1 mm<sup>2</sup> it is assumed that the fit is picking a bad hit, thus degrading the quality of the fit. The bad hit is identified by studying the meantime correlation MT1 versus MT2. The bad hit is then removed and a 3-hit fit is tried. Finally, if the  $\chi^2$  of the 3-hit segment is smaller than 1 mm<sup>2</sup> the fit is kept, otherwise the fit is rejected. In case of several fits, the one with the largest number of hits, and then the one with the best  $\chi^2$  is considered.

We note that, with the new algorithm, the majority of old 4-hit segments with  $\chi^2 > 1 \text{ mm}^2$  ("delta-rays") are transformed in good 3-hit segments (with the associated improved precision in the measured position and angle). The old segments with 3 hits and  $\chi^2 > 1 \text{ mm}^2$  are just a few (1.4%) and low-quality, as shown in Figure 12(right). Cutting them just adds to the geometric I-beam cell inefficiency.

We now verify that with the use of this simple new algorithm, the muon detection procedure is very insensitive to the noise, up to the smallest measured filter of 5.

We proceed by selecting events with a good segment ( $\chi^2 < 1 \text{ mm}^2$ ) in superlayer  $\phi_2$  and we study superlayer  $\phi_1$ . As measured in the previous subsection, the effect of noise in superlayer  $\phi_2$  is a factor of 2 smaller than in superlayer  $\phi_1$ .

There are several situations that can be considered to happen in the presence of noise hits:

- 1. A 3-hit segment incorporates a noise hit and is promoted to 4-hit. This would change the relative fractions of events with 4-hit and 3-hit segments.
- 2. One hit in a 4-hit segment is masked by a noise hit, the remaining segment is degraded to 3-hit. Again, this would change the relative fractions of events with 4-hit and 3-hit segments, but in the opposite direction.
- 3. Several hits from a good segment associate with a noise hit to give a second lower quality fit. This would change the fraction of events with a second fit.
- 4. The proportion of events without a segment changes.

We have studied these four possibilities, using the data. However as it turns out that all effects are very small, only the effects involving 4-hit segments are visible. The ones involving 3-hit or no fit events are negligible as they are proportional, in addition, to their small fractions ( $\sim 12\%$  and  $\sim 4\%$  respectively).

To disentangle effects #1 and #2 we have applied the following method: we simulate a filter-10 physics sample, by mixing the events of Run 624 (source off) with the events of noise of Run 650 (filter 10). In this case, only effect



Figure 22: The noise cell occupancies as a function of the cell number for the three superlayers. The left plot was obtained with the gamma source off. The right plot is for gamma irradiation corresponding to a filter of 10.



Figure 23: (Left) The noise cell occupancy, averaged over all the cells in a given superlayer, for the three superlayers, as a function of the source filter value. The fits are discussed in the text. (Right) The average noise cell occupancy dependence on the threshold value, for the three superlayers, and for gamma irradiation corresponding to a filter of 10.

Filter	No fit	4-h fit	3-h fit	4-h fit	3-h fit
value	(I-beam)	fraction	fraction	w/ 2nd fit	w/ 2nd fit
source off	$3.6 \pm 0.1$	$88.3\pm0.1$	$11.7 \pm 0.1$	$4.1 \pm 0.1$	$5.2 \pm 0.3$
100	$3.9\pm0.1$	$88.0\pm0.2$	$12.0\pm0.2$	$4.1 \pm 0.1$	$5.3 \pm 0.4$
50	$3.4\pm0.1$	$87.6\pm0.2$	$12.4\pm0.2$	$4.4 \pm 0.1$	$5.8 \pm 0.4$
10	$3.7\pm0.1$	$86.8\pm0.1$	$13.2\pm0.1$	$4.5\pm0.1$	$5.8 \pm 0.3$
5	$3.6\pm0.1$	$85.6\pm0.1$	$14.4\pm0.1$	$5.2\pm0.1$	$5.8\pm0.3$

Table 7: The measured numbers (%) for all the fractions discussed in this subsection (see text), corresponding to the five gamma irradiation levels studied in the present analysis. All events must have a segment in superlayer  $\phi_2$ .

#1 is relevant. The fraction of events with 4-hit segments over the sum of events with 3-hit and 4-hit segments both in the original and modified Run 624 is  $87.7\% \pm 0.2\%$ . Effect #1 is thus confirmed to be negligible.

Effects #2, #3, and #4 were studied using the data. Runs with different levels of gamma irradiation (source off; filter 100, 50, 10, and 5) were analyzed, and the results compared. In all these runs, the chamber was operated at nominal conditions except for filter 5. Typical wire currents in superlayer  $\phi_1$  for filter 10 were ~ 6  $\mu$ A at nominal voltages. In the run with filter 5,  $V_{wire}$  was reduced to 3570 V in superlayer  $\phi_1$  in order to maintain currents below the 10  $\mu$ A limit. The other two superlayers were operated at nominal conditions. No effect of this reduced voltage on the results below is expected, and none has been observed, with the exception of the hit position resolution. This case is discussed later explicitly.

Figures 24 show the fractions of events with at least one segment in superlayer  $\phi_1$ , where the best segment is 4-hit (left) or 3-hit (right), as a function of the filter value. Note that the sum of the two numbers must be one by definition. The data points are well reproduced by a fit to eqn. 1, where the parameter *k* has been fixed to its known value of 0.88. The evolution of the data points is interpreted as caused by effect #2. Note that the size of the effect agrees very well with the result of a simple-minded calculation. More important is that, even for a filter value of 5, the size of the effect is very small. For a filter value of 5, the fractions change by only 2.7%.

To test effect #3 we have studied the evolution of the fraction of events where a second segment in superlayer  $\phi_1$  has been reconstructed, as a function of the filter value. In Figure 25(left) the case where the best segment in superlayer  $\phi_1$  has 4 hits is illustrated. Again the data points are well reproduced by a fit to eqn. 1, where the parameter k has been fixed to its known value of 0.88. This time however, the offset value (measured when the source was off) is dominated by events with two beam muons. Only the differences with respect to the offset are meaningful. For a filter value of 5, the fraction of extra events with a second fit increases by only 1.2%. In the case where the best segment in superlayer  $\phi_1$  has 3 hits we observe no statistically significant variation.

To compute the evolution of the fraction of events with no fit (effect #4) is impossible because of the DAQ inefficiency described in Section 3. We have argued above that the change should be negligible anyway. It was possible, at the very least, to check the evolution of the fraction of events with no fit due to the I-beam inefficiency. The result is displayed in Figure 25(right). Again, no statistically significant variation was observed.

Table 7 details the actual measured numbers for all the fractions discussed in this subsection, corresponding to the five gamma irradiation levels studied in the present analysis.

Finally, the evolution of the chamber performance parameters (hit position resolution (left) and cell efficiency (right)) in superlayer  $\phi_1$ , as a function of the filter value is presented in Figure 26 and in Table 8. To simplify the comparison, in Figure 26(left), the resolution for filter 5 has been corrected from the measured value at  $V_{wire} = 3570$  V, to the corresponding resolution at nominal  $V_{wire} = 3600$  V using the measured dependence on the wire voltage (Figure 17(right)). Also, to be consistent with the values of the previous sections, the efficiencies in Figure 26(right) have been calculated using the old fitting algorithm. In both cases, no significant dependence on the gamma irradiation level is observed. Only for larger discriminator threshold levels (30 mV in Figure 21(right) and in Table 5) a small dependence of the efficiency on the noise rate has been measured.

## 7 Interference with RPC

To test a possible disturbing influence of the RPC on the DT noise levels, the measurements discussed in the previous sections were analyzed for RPC HV on and off conditions. No difference has ever been observed. Even for the most sensitive sample (beam data when the DT HV was off) the size of the effect is consistent with zero.



Figure 24: The fractions of events with at least one segment in superlayer  $\phi_1$ , where the best segment is 4-hit (left) or 3-hit (right), as a function of the filter value. Note that the sum of the two numbers must be one by definition. All events must also have a segment in superlayer  $\phi_2$ . The fits are discussed in the text.



Figure 25: (Left) The fraction of 4-hit  $\phi_1$ -segment events where a second segment in superlayer  $\phi_1$  has been reconstructed, as a function of the filter value. The fit is discussed in the text. (Right) The fraction of events with no fit in the I-beam region of superlayer  $\phi_1$ , as a function of the source filter. No significant dependence is observed as indicated by the horizontal line. In both plots all events must have a segment in superlayer  $\phi_2$ .



Figure 26: The hit position resolution (left) and cell efficiency (right) in superlayer  $\phi_1$ , as a function of the filter value. All events must also have a segment in superlayer  $\phi_2$ . The resolution for filter 5 has been corrected as explained in the text. The efficiencies have been calculated using the old fitting algorithm. No significant dependence is observed as indicated by the horizontal line.

Filter	Meantime	Residuals	Efficiency
value	resolution	resolution	(old fit)
source off	$191 \pm 2$	$186 \pm 2$	$99.96\pm0.01$
100	$190 \pm 2$	$188 \pm 2$	$99.98 \pm 0.01$
50	$193 \pm 2$	$186 \pm 2$	$99.99\pm0.01$
10	$193 \pm 2$	$190 \pm 2$	$99.95\pm0.01$
5	$192\pm2$	$193\pm2$	$99.97\pm0.01$

Table 8: The hit position resolution ( $\mu$ m) and cell efficiency (%) in superlayer  $\phi_1$ , as a function of the filter value. All events must also have a segment in superlayer  $\phi_2$ . The resolution for filter 5 has been corrected as explained in the text. The efficiencies have been calculated using the old fitting algorithm.

We conclude that the interference can be neglected.

# 8 ROB and HPTDC design validation

In the DT chambers to be installed in CMS, the ROBs will be located inside the front C-profiles of the honeycomb panel, in (so-called) minicrates, together with the Trigger Boards housing the BTI and TRACO trigger electronics.

The ROBs receive the discriminated signals from the front-end electronics sitting inside the gas volume of the superlayers. Each ROB can digitize up to 128 differential signals, and is built around a 32-channel high performance TDC (HPTDC) chip, developed by the CERN/EP Microelectronics group [9]. This highly programmable device provides a measurement of the hit arrival relative time inside a programmable match window, chosen to accommodate the maximum drift time. Other programmable parameters are the trigger latency, the reject window (the time before hits are removed from the L1 buffers), and the search window (extended window to search hits in the buffers, as they are not necessarily stored in strict chronological order). These parameters are illustrated schematically in the time diagram of Figure 27. One of the main features of this TDC is its ability to handle overlapping triggers, as an individual hit may fall inside several time windows. The tested HPTDC chips belong to the 2001 engineering run version.

In a ROB, there are four HPTDC chips configured in a clock synchronous token ring. One of them is programmed to be the master, controlling the token of the readout data-ready/get-data handshake protocol. The programming



Figure 27: Time diagram for HPTDC operation.

and monitoring of the TDCs is performed via a JTAG interface, included in a parallel bus that carries also the trigger and other control signals (event reset, bunch reset, etc). The data coming from the TDCs are sent out of the ROB through a 20 MHz LVDS serializer. The ROB is equipped with the necessary logic to operate in a test pulse mode, and also contains an over-current protection circuitry.

The main goal of this test was to validate the operation of the HPTDC and the ROB design under real chamber conditions. The ROB was designed at CIEMAT and the version used is the final one. The actual board used was one of the preseries of the mass production run. It was particularly important to test that the system can stand high hit rates, and cope with noisy chamber wires.

For this purpose, we connected one ROB to 96 channels from the 3 superlayers corresponding to the chamber region containing the beam. Trigger signals, provided by the set of scintillators in the beam line, were synchronized to the ROB system clock, and non-synchronized signals were fed into two ROB channels for relative time measurement (and providing redundant trigger information). During data taking, the latency was set to 1.1  $\mu$ s, the reject window to 1.3  $\mu$ s, and the matching window in the 700 - 900 ns range.

The correct operation of the system was confirmed. Data taken with the ROB were analyzed and all results concerning single wire efficiencies, meantime values, hit position resolutions, and drift velocities, were fully consistent with the corresponding ones obtained in Section 4. The meantime values and corresponding drift velocities for the three superlayers in a run with ROB readout are summarized in Table 9 (to be compared to the numbers in Table 1). The hit position resolutions and cell efficiencies appear in Table 10 (to be compared to Table 3). In the runs with high gamma irradiation levels, the effective noise increase was observed but had no effect on the TDC behavior.

In the second period the muon beam had a 25 ns bunch structure and a higher intensity (a factor 4 in triggers/s when compared to the first period). We observed occasionally TDC messages indicating buffer overflows due to two noisy channels in the MHz range in one TDC. It is important to note that this noise is flagged and it only affects the corresponding group of 8 channels which includes the noisy wire, without any loss of hits in other groups (as shown by the TDC debug information in Table 11). When the hit rate is in the kHz range, as in normal operation, the buffers are far from overflow. Noisy channels can be easily disabled to avoid data losses.

# 9 Conclusions

Test beam results obtained at GIF with the first produced CMS MB2 DT chamber have been presented. The chamber calibration and wire alignment procedure used in the data analysis has been described in detail using a typical run for illustration purposes. It has been shown that the performance of the chamber, coupled to an RPC, is satisfactory and fulfills all requirements. Results obtained from the comparison of the data taken in several operating conditions are in good agreement with test beam results from previous superlayer prototypes. No degradation in the chamber performance was found even with noise rates higher than the maximum ones expected in any DT chamber during normal LHC operation. In addition to this, the design of the ROB with the HPTDCs has been validated.

# 10 Acknowledgments

We acknowledge the efforts of several technicians at CIEMAT who made possible the construction, test, transport and set up of the MB2 chamber.

	SL $\theta$	SL $\phi_1$	SL $\phi_2$
MTL1 (±0.02)	376.4	380.3	381.0
MTR1	382.1	380.2	382.0
MTL2	376.9	378.2	379.9
MTR2	381.4	380.7	383.0
Average MT	379.2	379.9	381.5
$\Delta$ MT1	$\pm 2.8$	$\pm 0.1$	$\pm 0.5$
$\Delta$ MT2	$\pm 2.3$	$\pm 1.3$	$\pm 1.6$
Drift velocity $(\pm 0.3)$	55.38	55.28	55.04

Table 9: Summary of meantime values (ns) and corresponding drift velocities ( $\mu$ m/ns) in a run with ROB readout.

	SL θ	SL $\phi_1$	SL $\phi_2$
MTL1	$188.1\pm0.4$	$178.6\pm0.4$	$184.9\pm0.4$
MTR1	$184.5\pm0.4$	$189.4\pm0.4$	$184.5\pm0.4$
MTL2	$187.6\pm0.4$	$179.1\pm0.4$	$183.1\pm0.4$
MTR2	$183.1\pm0.4$	$189.8\pm0.4$	$178.1\pm0.4$
Residual layer #1	$181.1\pm0.4$	$176.8\pm0.4$	$177.1\pm0.4$
Residual layer #2	$182.9\pm0.5$	$182.9\pm0.5$	$184.1\pm0.5$
Residual layer #3	$180.5\pm0.5$	$184.1\pm0.5$	$181.7\pm0.5$
Residual layer #4	$180.4\pm0.4$	$177.1\pm0.4$	$175.6\pm0.4$
Efficiency	$99.97 \pm 0.01$	$99.97 \pm 0.01$	$99.97 \pm 0.01$

Table 10: Summary of hit position resolutions ( $\mu$ m) and cell efficiencies (%) in a run with ROB readout.

Max Occupancy	TDC 0	TDC 1	TDC 2	TDC 3
L1 Buffer (ch. 0-7)	6	16	14	11
L1 Buffer (ch. 8-15)	17	17	21	12
L1 Buffer (ch. 16-23)	16	254	5	5
L1 Buffer (ch. 24-31)	13	15	0	0
Trigger FIFO	3	3	3	2
Redout FIFO	56	120	79	59

Table 11: Debug information for the four HPTDC chips.

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